

UT54LVDM228 Quad 2x2 400 Mbps Crosspoint Switch

March 13, 2002



FEATURES

- ❑ 400.0 Mbps low jitter fully differential data path
- ❑ 200MHz clock channel
- ❑ 3.3 V power supply
- ❑ 10mA LVDS output drivers
- ❑ Input receiver fail-safe
- ❑ Cold sparing all pins
- ❑ Output channel-to-channel skew is 120ps max
- ❑ Configurable as quad 2:1 mux, 1:2 demux, repeater or 1:2 signal splitter
- ❑ Fast propagation delay of 3.5ns max
- ❑ Receiver input threshold $< \pm 100$ mV
- ❑ Radiation-hardened design; total dose irradiation testing to MIL-STD-883 Method 1019
 - Total-dose: 300 krad(Si) and 1 Mrad(Si)
 - Latchup immune (LET > 100 MeV-cm²/mg)
- ❑ Packaging options:
 - 64-lead flatpack
- ❑ Standard Microcircuit Drawing 5962-01537
 - QML Q and V compliant part
- ❑ Compatible with ANSI/TIA/EIA 644-1995 LVDS Standard

INTRODUCTION

The UT54LVDM228 is a quad 2x2 crosspoint switch utilizing Low Voltage Differential Signaling (LVDS) technology for low power, high speed operation. Data paths are fully differential from input to output for low noise generation and low pulse width distortion. The non-blocking design allows connection of any input to any output or outputs on each switch. LVDS I/O enable high speed data transmission for point-to point or multi-drop interconnects. This device can be used as a high speed differential crosspoint, 2:1 mux, 1:2 demux, repeater or 1:2 signal splitter. The mux and demux functions are useful for switching between primary and backup circuits in fault tolerant systems. The 1:2 signal splitter and 2:1 mux functions are useful for distribution of a bus across several rack-mounted backplanes.

The individual LVDS outputs can be put into **Tri-State** by use of the enable pins.

All pins have Cold Spare buffers. These buffers will be high impedance when V_{DD} is tied to V_{SS} .

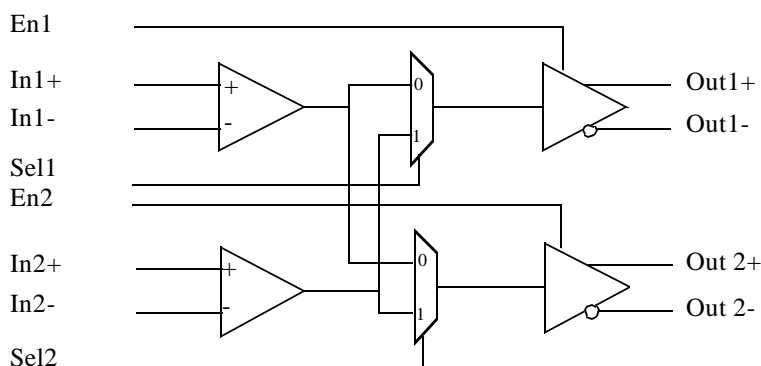


Figure 1a. UT54LVDM228 Crosspoint Switch Block Diagram
(Partial - see Page 2 for complete diagram)

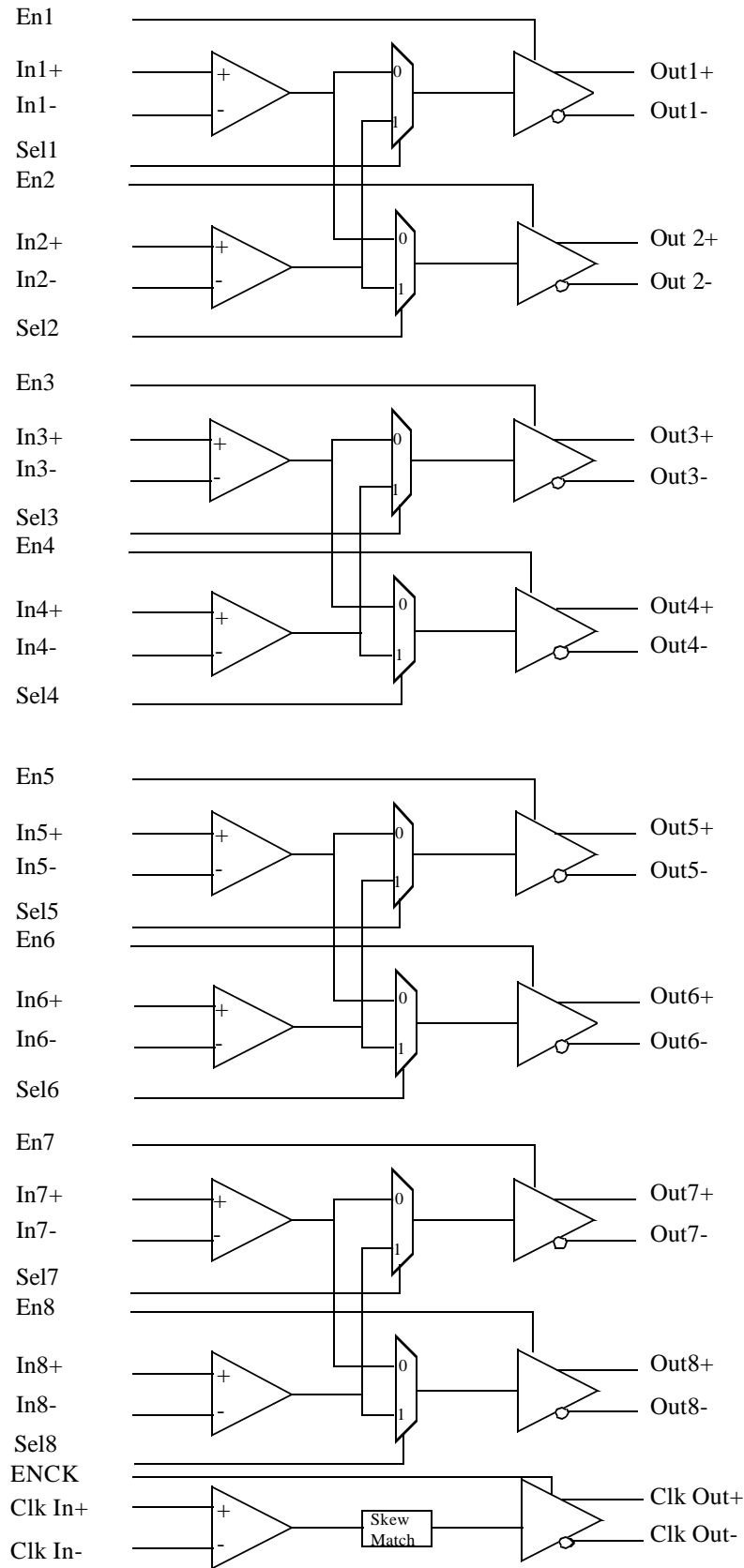


Figure 1b. UT54LVDM228 Crosspoint Switch Block Diagram

En1	1	UT54LVDM228 Crosspoint Switch	64	Sel1
In1+	2		63	Out1+
In1-	3		62	Out1-
En2	4		61	Sel2
In2+	5		60	Out2+
In2-	6		59	Out2-
V _{DD}	7		58	V _{DD}
V _{SS}	8		57	V _{SS}
In3+	9		56	Sel3
In3-	10		55	Out3+
En3	11		54	Out3-
In4+	12		53	Sel4
In4-	13		52	Out4+
En4	14		51	Out4-
ENCK	15		50	V _{DD}
CLK In+	16		49	CLK Out+
CLK In-	17		48	CLK Out-
V _{SS}	18		47	V _{SS}
En5	19		46	Sel5
In5+	20		45	Out5+
In5-	21		44	Out5-
En6	22		43	Sel6
In6+	23		42	Out6+
In6-	24		41	Out6-
V _{DD}	25		40	V _{DD}
V _{SS}	26		39	V _{SS}
In7+	27		38	Sel7
In7-	28		37	Out7+
En7	29		36	Out7-
In8+	30		35	Sel8
In8-	31		34	Out8+
En8	32		33	Out8-

Figure 2. UT54LVDS228 Pinout

TRUTH TABLE

Sel1	Sel2	Out1	Out2	Mode
0	0	In1	In1	1:2 splitter
0	1	In1	In2	Repeater
1	0	In2	In1	Switch
1	1	In2	In2	1:2 splitter

PIN DESCRIPTION

Name	# of Pins	Description
In+	8	Non-inverting LVDS input
In-	8	Inverting LVDS input
Out+	8	Non-inverting LVDS output
Out-	8	Inverting LVDS Output
En	8	A logic low on the enable puts the LVDS output into Tri-State and reduces the supply current
ENCK	1	A logic low on the enable puts the LVDS output into Tri-State and reduces the supply current
Sel	8	2:1 mux input select
V _{SS}	6	Ground
V _{DD}	5	Power supply
CLK In+	1	Non-Inverting Clock LVDS Input
CLK In-	1	Inverting clock LVDS Input
CLK Out+	1	Non-Inverting Clock LVDS Output
CLK Out-	1	Inverting Clock LVDS Output

APPLICATIONS INFORMATION

The UT54LVDM228 provides three modes of operation. In the 1:2 splitter mode, the two outputs are copies of the same single input. This is useful for distribution / fan-out applications. In the repeater mode, the device operates as a 9channel LVDS buffer. Repeating the signal restores the LVDS amplitude, allowing it to drive another media segment. This allows for isolation of segments or long distance applications or buffers standard LVDS to 10mA multi-op drivers. The switch mode provides a crosspoint function. This can be used in a system when primary and redundant paths are supported in a fault tolerant application.

The intended application of these devices and signaling technique is for both point-to-point baseband (single termination) and multipoint (double termination) data transmissions over controlled impedance media. The transmission media may be printed-circuit board traces, backplanes, or cables. (Note: The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media, the noise coupling to the environment, and other application specific characteristics.

Input Fail-Safe:

The UT54LVDM228 also supports OPEN, shorted and terminated input fail-safe. Receiver output will be HIGH for all fail-safe conditions.

PCB layout and Power System Bypass:

Circuit board layout and stack-up for the UT54LVDM228 should be designed to provide noise-free power to the device. Good layout practice also will separate high frequency or high level inputs and outputs to minimize unwanted stray noise pickup, feedback and interference. Power system performance may be greatly improved by using thin dielectrics (4 to 10 mils) for power/ground sandwiches. This increases the intrinsic capacitance of the PCB power system which improves power supply filtering, especially at high frequencies, and makes the value and placement of external bypass capacitors less critical. External bypass capacitors should include both RF ceramic and tantalum electrolytic types. RF capacitors may use values in the range 0.01 μ F to 0.1 μ F. Tantalum capacitors may be in the range of 2.2 μ F to 10 μ F. Voltage rating for tantalum capacitors should be at least 5X the power supply voltage being used. It is recommended practice to use two vias at each power pin of the UT54LVDM228, as well as all RF bypass capacitor terminals. Dual vias reduce the interconnect inductance and extends the effective frequency range of the bypass components.

The outer layers of the PCB may be flooded with additional ground plane. These planes will improve shielding and isolation, as well as increase the intrinsic capacitance of the power supply plane system. Naturally, to be effective, these planes must be tied to the ground supply plane at frequent intervals with vias. Frequent via placement also improves signal integrity in signal transmission lines by providing short paths for image currents which reduces signal distortion. The planes should be pulled back from all transmission lines and component mounting pads a distance equal to the width of the widest transmission line from the internal power or ground plane(s) whichever is greater. Doing so minimizes effects on transmission line impedances and reduces unwanted parasitic capacitances at component mounting pads.

Compatibility with LVDS standard:

In backplane multidrop configurations, with closely spaced loads, the effective differential impedance of the line is reduced. If the mainline has been designed for 50 Ω differential impedance, the loading effects may reduce this to the 35 Ω range depending upon spacing and capacitance load. Terminating the line with a 35 Ω load is a better match than with 50 Ω and reflections are reduced.

ABSOLUTE MAXIMUM RATINGS¹(Referenced to V_{SS})

SYMBOL	PARAMETER	LIMITS
V_{DD}	DC supply voltage	-0.3 to 4.0V
V_{IO}	Voltage on any pin	-0.3 to ($V_{DD} + 0.3V$)
T_{STG}	Storage temperature	-65 to +150°C
P_D	Maximum power dissipation	800mW
T_J	Maximum junction temperature ²	+150°C
Θ_{JC}	Thermal resistance, junction-to-case ³	22°C/W
I_I	DC input current	$\pm 10mA$

Notes:

1. Stresses outside the listed absolute maximum ratings may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond limits indicated in the operational sections of this specification is not recommended. Exposure to absolute maximum rating conditions for extended periods may affect device reliability and performance.
2. Maximum junction temperature may be increased to +175°C during burn-in and life test.
3. Test per MIL-STD-883, Method 1012.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS
V_{DD}	Positive supply voltage	3.3 to 3.6V
T_C	Case temperature range	-55 to +125°C
V_{IN}	DC input voltage, receiver inputs	0 to 2.4V
	DC input voltage, logic inputs	0 to V_{DD} for EN, SEL

DC ELECTRICAL CHARACTERISTICS ^{1,2}(V_{DD} = 3.3V ± 0.3V; -55°C < T_C < +125°C)

SYMBOL	PARAMETER	CONDITION	MIN	MAX	UNIT
CMOS/TTL DC SPECIFICATIONS (EN, SEL)					
V _{IH}	High-level input voltage		2.0	V _{CC}	V
V _{IL}	Low-level input voltage		GND	0.8	V
I _{IH}	High-level input current	V _{IN} =3.6V; V _{DD} = 3.6V	-10	+10	μA
I _{IL}	Low-level input current	V _{IN} =0V; V _{DD} = 3.6V	-10	+10	μA
V _{CL} ³	Input clamp voltage	I _{CL} =-18mA		-1.5	V
I _{CS}	Cold Spare Leakage	V _{IN} =3.6V, V _{DD} =V _{SS}	-20	+20	μA
LVDS OUTPUT DC SPECIFICATIONS (OUT+, OUT-)					
V _{OD}	Differential Output Voltage	R _L = 35Ω V _{OS} =($\frac{V_{OH}+V_{OL}}{2}$)	250	450	mV
ΔV _{OD}	Change in V _{OD} between complimentary output states			35	mV
V _{OS}	Offset Voltage		1.0	1.45	V
ΔV _{OS}	Change in V _{OS} between complimentary output states	R _L =35Ω		35	mV
I _{OZ} ⁴	Output Tri-State Current	Tri-State output, V _{OUT} =V _{DD} or GND		±10	μA
I _{CSOUT}	Cold Sparing Leakage Current	V _{OUT} =3.6V, V _{DD} =V _{SS}	-20	+20	μA
I _{OS}	Output Short Circuit Current	V _{OUT} + OR V _{OUT} = 0 V		-25	mA
LVDS RECEIVER DC SPECIFICATIONS (IN+, IN-)					
V _{TH}	Differential Input High Threshold	V _{CM} = +1.2V; V _{CC} =3.3V		+100	mV
V _{TL}	Differential Input Low Threshold	V _{CM} = +1.2V; V _{CC} =3.3V	-100		mV
V _{CMR}	Common Mode Voltage Range	V _{ID} =200mV, V _{DD} = 3.3V	0.2	2.00	V
I _{IN}	Input Current	V _{IN} = +2.4V, V _{DD} = 3.6V or 0V	-10	+10	μA
		V _{IN} = 0V, V _{DD} = 3.6V or 0V	-10	+10	μA
I _{CSIN}	Cold Sparing Leakage Current	V _{IN} =3.6V, V _{DD} =V _{SS}	-20	+20	μA
Supply Current					
I _{CCD}	Total Supply Current	R _L = 35Ω EN1 - EN8, ENCK = V _{DD}		220	ma
ICCZ	Tri-State Supply Current	EN1 - EN8, ENCK = V _{SS}		20	ma

Notes:

1. Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground.
2. Output short circuit current (I_{OS}) is specified as magnitude only, minus sign indicates direction only. Only one output should be shorted at a time, do not exceed maximum junction temperature specification.
3. Guaranteed by characterization.
4. Devices are tested @ $V_{DD}=3.3V$ only.

AC SWITCHING CHARACTERISTICS¹(V_{DD} = +3.3V ± 0.3V, T_A = -55 °C to +125 °C)

SYMBOL	PARAMETER	Conditions	MIN	MAX	UNIT
t _{SET} ²	Input to SEL Setup Time		1.5		ns
t _{HOLD}	Input to SEL Hold Time		1.5		ns
t _{SWITCH}	SEL to Switched Output			3.0	ns
t _{PHZ}	Disable Time (Active to Tri-State) High to Z			4.0	ns
t _{PLZ}	Disable Time (Active to Tri-State) Low to Z			4.5	ns
t _{PZH} ¹	Enable Time (Tri-State to Active) Z to High			10.0	ns
t _{PZL} ¹	Enable Time (Tri-State to Active) Z to Low			10.0	ns
t _{LHT}	Output Low-to-High Transition Time, 20% to 80%		290	600	ps
t _{HLT}	Output High-to-Low Transition Time, 80% to 20%		290	600	ps
t _{PLHD}	Propagation Low to High Delay	R _L =35Ω, C _L =10pf		3.5	ns
T _{PHLD}	Propagation High to Low Delay	R _L =35Ω, C _L =10pf		3.5	ns
T _{SKEW}	Pulse Skew T _{PHLD} - T _{PLHD}			300	ps
T _{CCS}	Output Channel-to-Channel Skew			120	ps

Notes:

1. Guaranteed by characterization.

2. T_{SET} and T_{HOLD} time specify that data must be in a stable state before and after SEL transition.

AC TIMING DIAGRAMS

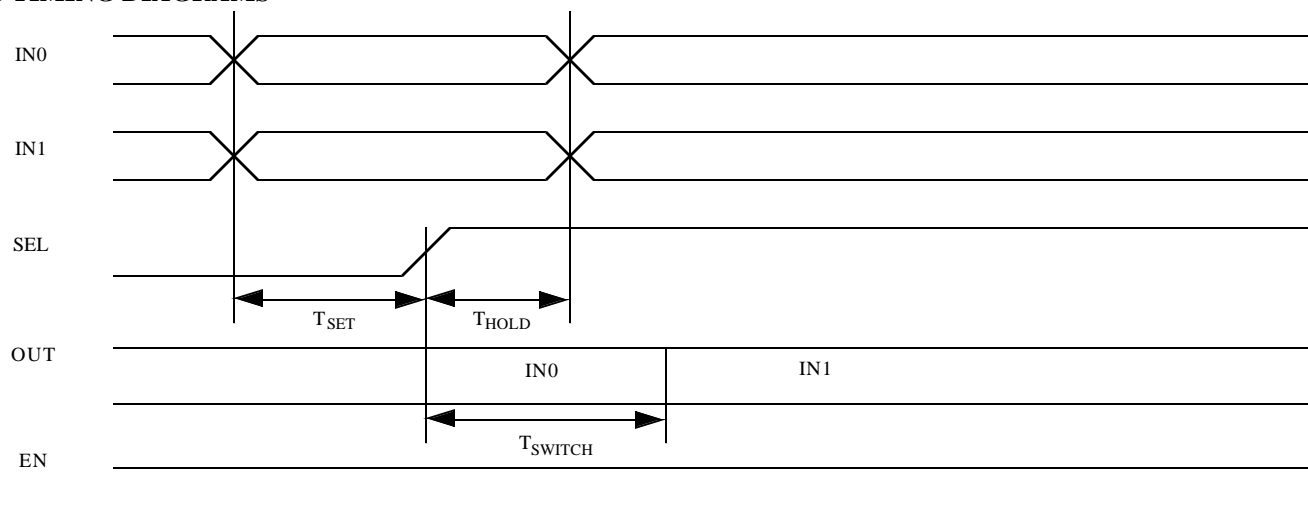


Figure 3. Input-to-Select Rising Edge Setup and Hold Times and Mux Switch Time

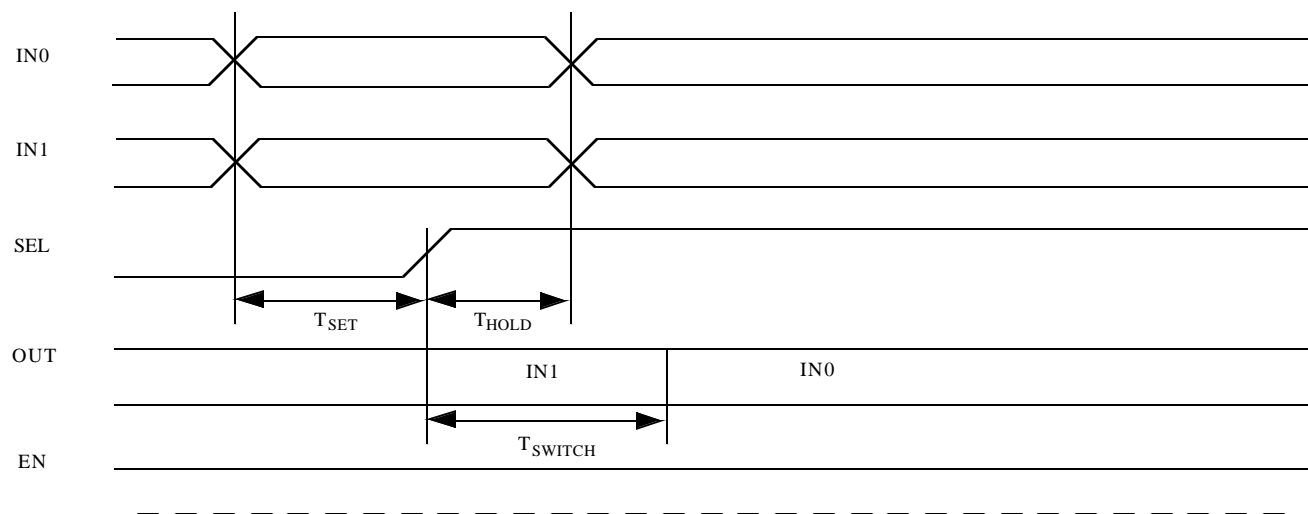


Figure 4. Input-to-Select Falling Edge Setup and Hold Times and Mux Switch Time

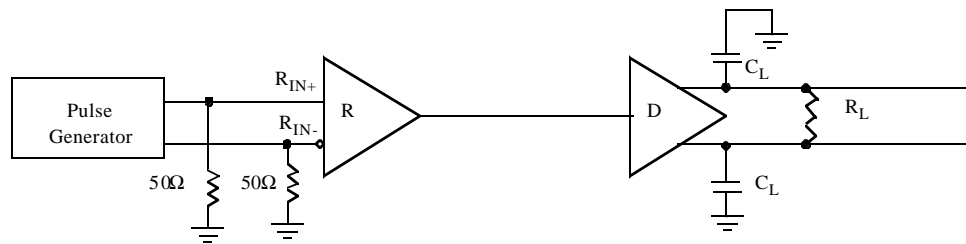


Figure 5. LVDS Output Load

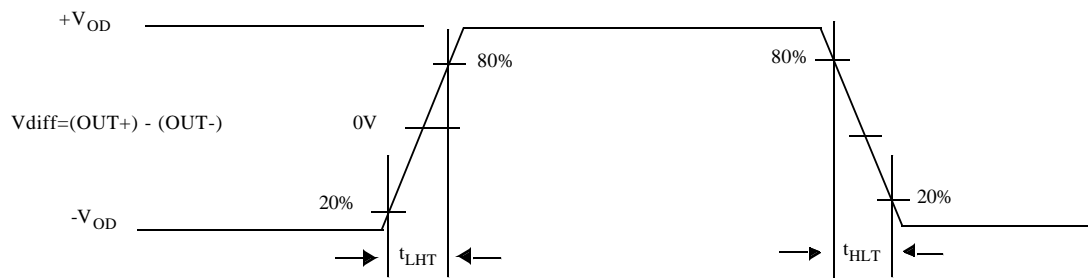


Figure 6. LVDS Output Transition Time

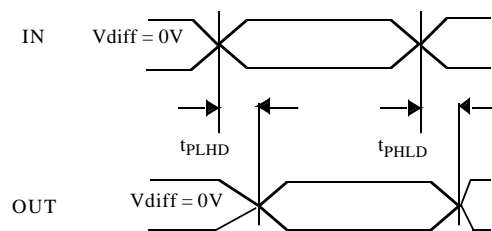


Figure 7. Propagation Delay Low-to-High and High-to-Low

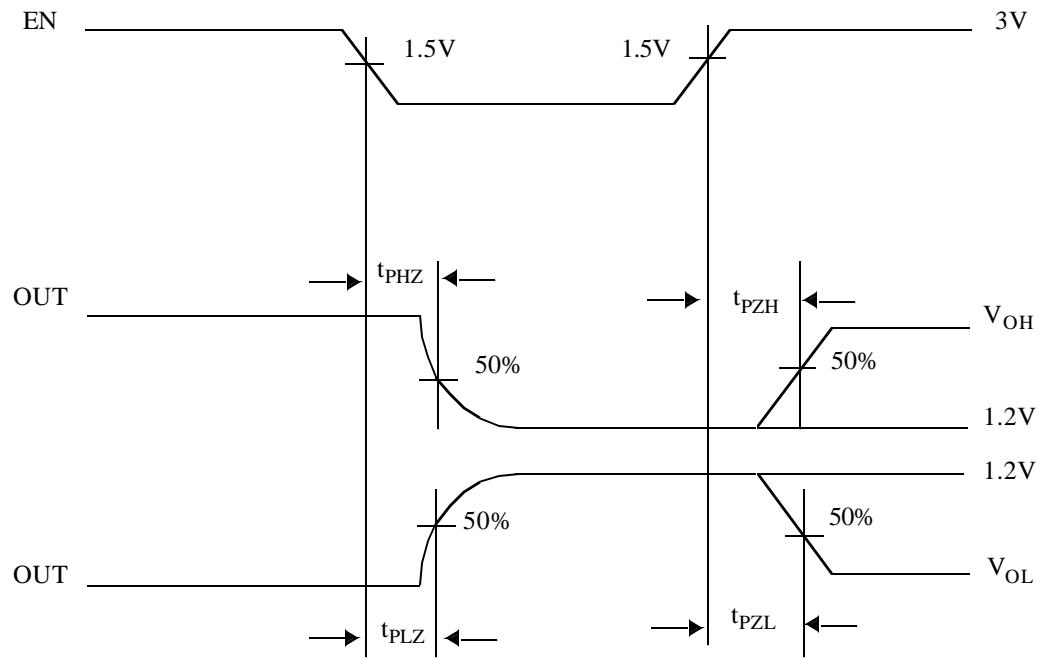


Figure 8. Output active to TRI-STATE and TRI-STATE to active

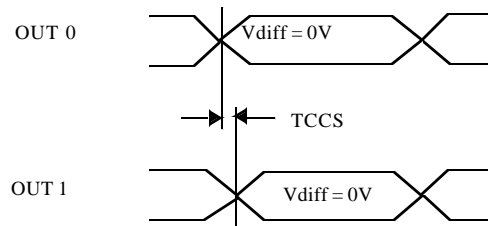


Figure 9. Output Channel-to-Channel Skew in 1:2 splitter mode

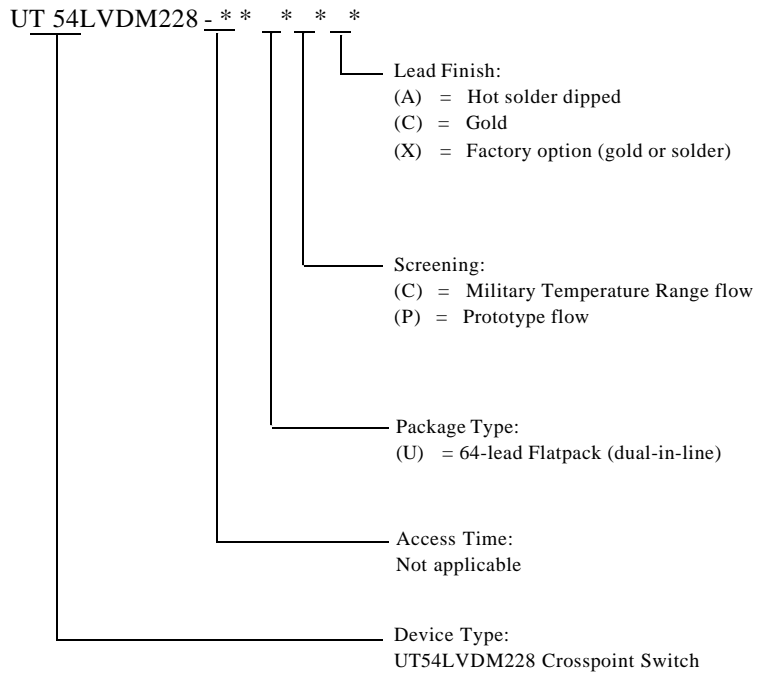
Technical drawing of a rectangular component with a central square feature. The drawing includes the following dimensions and tolerances:

- Top Left:** 0.025 BSC, 62 PLACES. Dimension line with arrows pointing to the top edge.
- Top Center:** PIN #1 ID MARK 6. Dimension line with an arrow pointing to a small square feature on the top edge.
- Top Right:** D 0.840 MAX. Dimension line with arrows pointing to the top edge.
- Bottom Left:** 0.009, 0.007 48 PLACES. Dimension line with arrows pointing to the bottom edge.
- Bottom Center:** E1 0.400. Dimension line with arrows pointing to the bottom edge.
- Bottom Right:** S1 0.000 MIN. (4) PLACES. Dimension line with arrows pointing to the bottom edge.
- Left Edge:** A 0.115, 0.095. Dimension line with arrows pointing to the left edge.
- Right Edge:** C 0.010, 0.006. Dimension line with arrows pointing to the right edge.
- Central Feature:** A square feature with rounded corners, labeled E2 0.225. Dimension line with arrows pointing to the central feature.
- Bottom Feature:** A rectangular feature on the bottom edge, labeled E3 0.060 TYP. Dimension line with arrows pointing to the bottom feature.
- Other Dimensions:** L 0.350 TYP., 0.250. Dimension line with arrows pointing to the bottom edge. D 0.350, 0.340. Dimension line with arrows pointing to the bottom edge. D 0.036. Dimension line with arrows pointing to the bottom edge.
- Surface Tolerances:**
 - Top Left: 7, 5. Surface texture symbol.
 - Bottom Left: 7, 5. Surface texture symbol.
 - Bottom Right: 7. Surface texture symbol.
- Feature Control Frames:**
 - Top Left: Ø 0.015 (M) H Δ-B (S) D (S)
 - Top Right: Ø 0.036 (M) H Δ-B (S) D (S)
 - Bottom Left: Ø 0.030, 0.013. Dimension line with arrows pointing to the bottom edge.
 - Bottom Right: Ø 0.040. Dimension line with arrows pointing to the bottom edge.

- ### Figure 10. 64-pin Flatpack

ORDERING INFORMATION

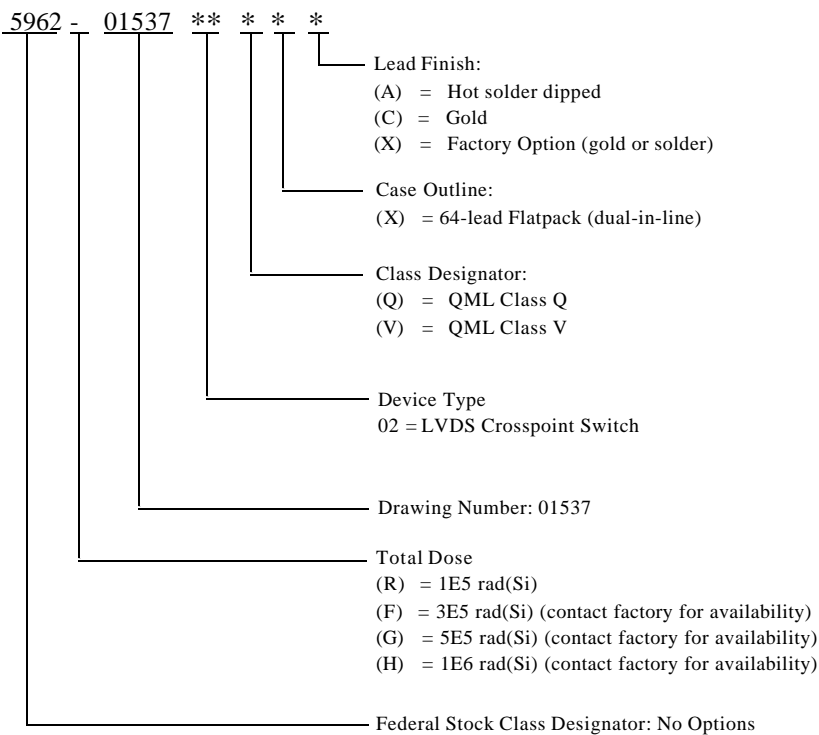
UT54LVDM228 Crosspoint Switch:



Notes:

1. Lead finish (A,C, or X) must be specified.
2. If an "X" is specified when ordering, then the part marking will match the lead finish and will be either "A" (solder) or "C" (gold).
3. Prototype flow per UTM Manufacturing Flows Document. Tested at 25°C only. Lead finish is GOLD ONLY. Radiation neither tested nor guaranteed.
4. Military Temperature Range flow per UTM Manufacturing Flows Document. Devices are tested at -55°C, room temp, and 125°C. Radiation neither tested nor guaranteed.

UT54LVDM228 Crosspoint Switch: SMD



- Notes:**
1. Lead finish (A, C, or X) must be specified.
 2. If an "X" is specified when ordering, part marking will match the lead finish and will be either "A" (solder) or "C" (gold).
 3. Total dose radiation must be specified when ordering. QML Q and QML V not available without radiation hardening.